

**Search Notes****Application/Control No.**

10/827,375

**Examiner**

Paul D. Kim

**Applicant(s)/Patent under Reexamination**

LIANG ET AL.

**Art Unit**

3729

**SEARCHED**

Class	Subclass	Date	Examiner
29	592.1 602.1 605 606 846	7/18/2006	PK
216	39, 41		
336	65,83 200		
	206-208		
	220-223		
	232		
257	531		
438	238 381		
	106 107		

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Reviewed Parent Application 10/200,194 (US PAT. 6,876,285)	7/18/2006	PK
Text Search EAST/NPL (IEEE)	7/18/2006	PK

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner